



SLD90N03T 30V N -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Application

- ☑ PWM Application
- ☑ Load Switch
- ☑ Power Management

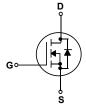
Features

- N-Channel:30V 90A

 $R_{DS(on)Typ}$ = 3.8m Ω @V_{GS} = 10 V $R_{DS(on))Typ}$ = 5.5m Ω @V_{GS} = 4..5V

- Very Low On-resistance R_{DS(ON)}
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter	SLD90N03T	Units
V_{DSS}	Drain-Source Voltage	30	V
_	Drain Current - Continuous (T _C = 25°C)	90	Α
Ι _D	- Continuous (T _C = 100°C)	58	Α
I _{DM}	Drain Current - Pulsed (Note 1)	360	Α
V_{GSS}	Gate-Source Voltage	±20	V
E _{AS}	Single Pulsed Avalanche Energy	90	mJ
P _D	Power Dissipation (T _C = 25°C)	90	W
R _{0JC}	Thermal Resistance, Junction to Case	1.67	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
T∟	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

^{*} Drain current limited by maximum junction temperature.

Units

Max

Package Marking

Symbol

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLD90N03T	SLD90N03T	D-Pak	Tape & Reel	2500	25000

Electrical Characteristics

Parameter

T_C = 25°C unless otherwise noted

Test Conditions

Min

Тур

Off Characteristics									
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 uA	30			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30 V, V _{GS} = 0 V			1	uA			
		V _{DS} = 24V, T _C = 125°C			10	uA			
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 20V, V_{DS} = 0 V$			100	nA			
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -20 V, V _{DS} = 0 V			-100	nA			

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \text{ uA}$	1.0	1.5	2.5	V
R _{DS(on)}	Static Drain-Source	V _{GS} = 10 V, I _D = 30A	1	3.8	4.5	2
	On-Resistance	V _{GS} = 4.5 V, I _D = 20A	1	5.5	7.0	mΩ

Dynamic Characteristics

Ciss	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	1	1950	1	pF
Coss	Output Capacitance		1	320	1	pF
C _{rss}	Reverse Transfer Capacitance			240	-	pF

Switching Characteristics

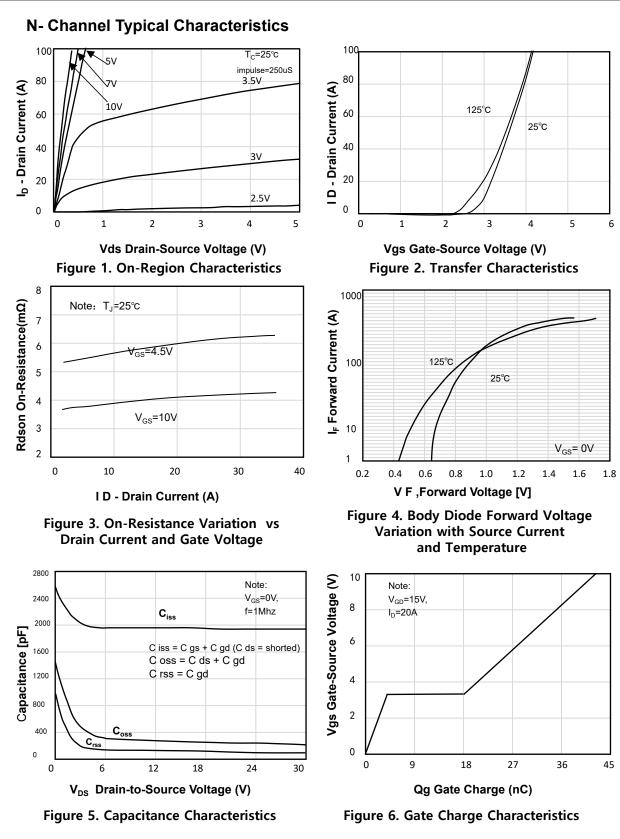
$t_{d(on)}$	Turn-On Delay Time		-	13		ns
t _r	Turn-On Rise Time	V _{GS} = 10 V, V _{DS} =15 V,	-	36	-	ns
$t_{\sf d(off)}$	Turn-Off Delay Time	$R_G = 3 \Omega, I_D = 30A$	-	43	-	ns
t _f	Turn-Off Fall Time	1		16		ns
Q_g	Total Gate Charge	V _{DS} = 15 V, I _D =30A,		42		nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V		4		nC
Q_{gd}	Gate-Drain Charge			14		nC

Drain-Source Diode Characteristics and Maximum Ratings

Is	Maximum Continuous Drain-Source Diode Forward Current	1	1	90	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current	-	-	360	Α
V _{SD}	Drain to Source Diode Forward Voltage, V GS = 0V, I SD = 30A, T J = 25°C	-	-	1.2	V
t _{rr}	Body Diode Reverse Recovery Time, I _F =20A,dI/dt=100A/μs	1	16	1	nS
Qrr	Body Diode Reverse Recovery Charge,I _F =20A,dI/dt=100A/µs	-	5		nC

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition: T J =25°C, V DD =15V, V G =10V, R G =25 Ω , L=0.5mH, I AS =19A
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



N- Channel Typical Characteristics (Continued)

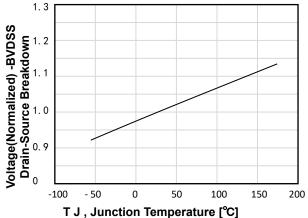


Figure 7. Breakdown Voltage Variation vs Temperature

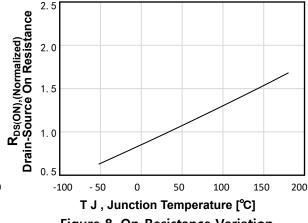


Figure 8. On-Resistance Variation vs Temperature

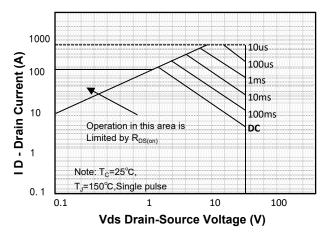
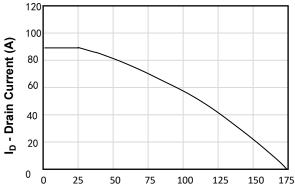


Figure 9. Maximum Safe Operating Area



T J -Junction Temperature(℃)

Figure 10. Maximum PContinuous Drain

Currentvs Case Temperature

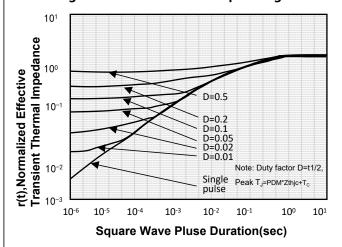
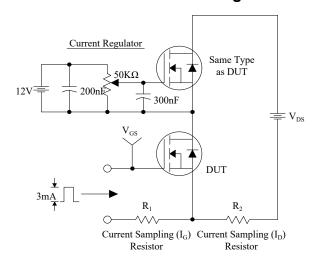
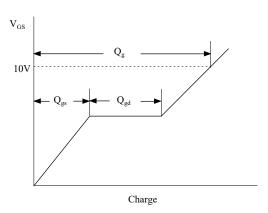


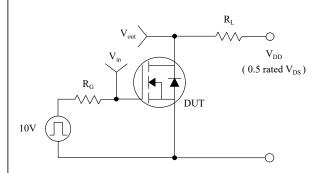
Figure 11. Transient Thermal Response Curve

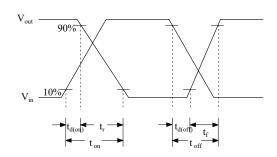
Gate Charge Test Circuit & Waveform



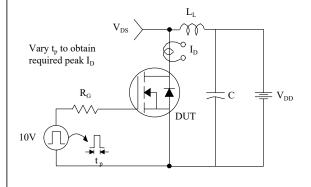


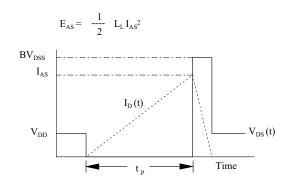
Resistive Switching Test Circuit & Waveforms



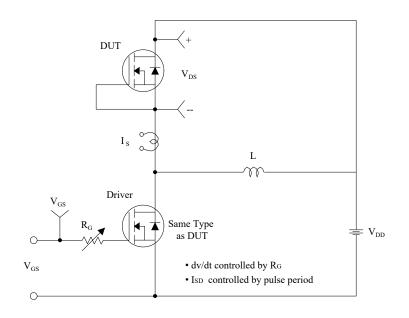


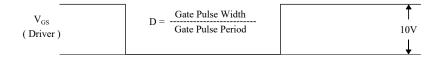
Unclamped Inductive Switching Test Circuit & Waveforms

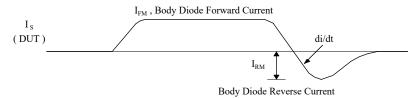


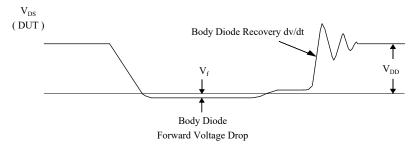


Peak Diode Recovery dv/dt Test Circuit & Waveforms

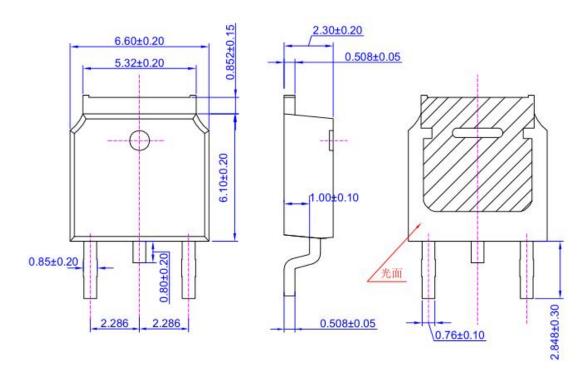


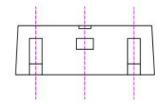






TO-252 OUTLINE





NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8 2.Undeclared tolerance \pm 0.25,Unmarked filletRmax=0.25

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